## Notice of References Cited Application/Control No. 10/561,187 Examiner Sarah Su Applicant(s)/Patent Under Reexamination ARAKI ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0083123 A1	06-2002	Freedman et al.	709/203
*	В	US-2003/0037237 A1	02-2003	Abgrall et al.	713/166
*	С	US-2003/0115142 A1	06-2003	Brickell et al.	705/51
*	D	US-6,574,611 B1	06-2003	Matsuyama et al.	705/57
*	Е	US-2004/0117660 A1	06-2004	Karaoguz et al.	713/201
*	F	US-2004/0165206 A1	08-2004	Aoki et al.	358/001.13
*	G	US-2004/0187018 A1	09-2004	Owen et al.	713/200
*	Н	US-2004/0208500 A1	10-2004	Kiyosu et al.	396/549
*	I	US-2004/0249961 A1	12-2004	Katsube et al.	709/229
*	J	US-2008/0133716 A1	06-2008	Rao et al.	709/220
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

_			
	*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
		C	
		<	
		W	
		X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.